

Features

- SiC MOSFET technology
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Very low switching losses
- Low reverse recovery (Qrr)
- 100% Avalanche tested, 100% Rg tested

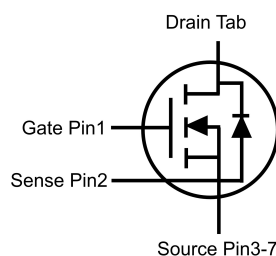
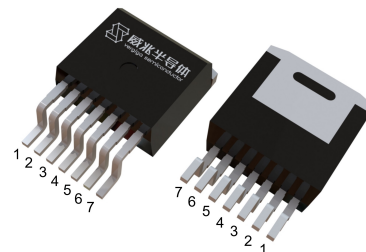


Halogen-Free

Part ID	Package Type	Marking	Packing
HCCC120R080H1	TO-263-7L	120R080H1	800pcs/Reel

V_{DS}	1200	V
$R_{DS(on),TYP@ V_{GS}=20V}$	80	mΩ
$I_D(\text{Silicon limited})$	37	A

TO-263-7L



Maximum ratings, at $T_A = 25^\circ\text{C}$, unless otherwise specified

Symbol	Parameter		Rating	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage		1200	V
V_{GSmax}	Gate-Source voltage (dynamic) AC ($f > 1\text{ Hz}$) ①		-10/+25	V
V_{GSop}	Gate-Source voltage (static) ②		-5/+20	V
I_D	Continuous drain current @ $V_{GS}=20V$ (Silicon limited)	$T_C = 25^\circ\text{C}$	37	A
I_D	Continuous drain current @ $V_{GS}=20V$ (Silicon limited)	$T_C = 100^\circ\text{C}$	26	A
I_{DM}	Pulse drain current tested, $V_{GS}=20V$ ③	$T_C = 25^\circ\text{C}$	96	A
EAS	Maximum avalanche energy, single pulsed ④		845	mJ
PD	Maximum power dissipation ⑤	$T_C = 25^\circ\text{C}$	221	W
		$T_C = 100^\circ\text{C}$	110	W
TSTG	Storage temperature range		-55 to 150	$^\circ\text{C}$
T_J	Operating junction temperature		-55 to 175	$^\circ\text{C}$

Thermal Characteristics

Symbol	Parameter	Typical	Max	Unit
$R_{\theta JC}$	Thermal resistance, junction-to-case ⑥	0.57	0.68	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal resistance, junction-to-ambient ⑦	50	60	$^\circ\text{C/W}$

Electrical Characteristics

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ T _J =25°C (unless otherwise stated)						
V(BR)DSS	Drain-source breakdown voltage	V _{GS} =0V, I _D =250μA	1200	--	--	V
I _{DSS}	Zero gate voltage drain current(T _J =25°C)	V _{DS} =1200V,V _{GS} =0V	--	--	50	μA
	Zero gate voltage drain current(T _J =125°C)⑧	V _{DS} =1000V,V _{GS} =0V	--	--	100	μA
I _{GSS}	Gate-body leakage current	V _{GS} =-5V,V _{DS} =0V	--	--	-100	nA
I _{GSS}	Gate-body leakage current	V _{GS} =20V,V _{DS} =0V	--	--	100	nA
V _{GS(th)}	Gate threshold voltage	V _{DS} =V _{GS} ,I _D =5mA	1.8	2.8	4.5	V
R _{DS(on)}	Drain-source on-state resistance ⑨	V _{GS} =20V, I _D =20A	--	80	100	mΩ
		T _J =100°C ⑧	--	96	--	mΩ
Dynamic Electrical Characteristics @ T _J = 25°C (unless otherwise stated)						
C _{iss}	Input capacitance ⑧	V _{DS} =800V,V _{GS} =0V, f=100kHz	--	1255	--	pF
C _{oss}	Output capacitance ⑧		--	80	--	pF
C _{rss}	Reverse transfer capacitance ⑧		--	5	--	pF
R _g	Gate resistance	f=1MHz	--	3.6	--	Ω
Q _g	Total gate charge ⑧	V _{DS} =800V,I _D =20A, V _{GS} =-5/20V	--	58	--	nC
Q _{gs}	Gate-source charge ⑧		--	21	--	nC
Q _{gd}	Gate-drain charge ⑧		--	17	--	nC
Switching Characteristics ⑧						
T _{d(on)}	Turn-on delay time	V _{DD} =800V, I _D =20A, R _G =2Ω, V _{GS} =-5/20V L=5.6mH (Fig17)	--	18	--	ns
T _r	Turn-on rise time		--	30	--	ns
T _{d(off)}	Turn-off delay time		--	30	--	ns
T _f	Turn-off fall time		--	48	--	ns
Source- Drain Diode Characteristics@ T _J = 25°C (unless otherwise stated)						
V _{SD}	Forward on voltage	I _{SD} =10A,V _{GS} =-5V	--	3.9	6	V
T _{rr}	Reverse recovery time ⑧	V _{DD} =800V	--	16	--	ns
Q _{rr}	Reverse recovery charge ⑧	I _{sd} =20A, V _{GS} =0V	--	39	--	nC
I _{rrm}	Peak Reverse Recovery Current ⑧	di/dt=500A/μs	--	4.3	--	A

NOTE:

- ① When using MOSFET Body Diode $V_{GSmax} = -10V/+25V$
- ② MOSFET can also safely operate at $-5/+20V$
- ③ Single pulse; pulse width limited by max junction temperature.
- ④ This maximum value is based on starting $T_J = 25^{\circ}\text{C}$, $L = 10mH$, $R_G = 25\Omega$, $I_{AS} = 13A$, $V_{GS} = 20V$; 100% FT tested at $L = 10mH$, $I_{AS} = 9A$.
- ⑤ The power dissipation P_d is based on $T_J(max)$, using junction-to-case thermal resistance $R_{\theta JC}$.
- ⑥ Thermal resistance from junction to soldering point (on the exposed drain pad). These tests are performed on a cool plate.
- ⑦ The value of $R_{\theta JA}$ is measured with the device in a still air environment with $T_A = 25^{\circ}\text{C}$.
- ⑧ Guaranteed by design, not subject to production testing.
- ⑨ Pulse width $\leq 380\mu s$; duty cycle $\leq 2\%$.

Typical Characteristics

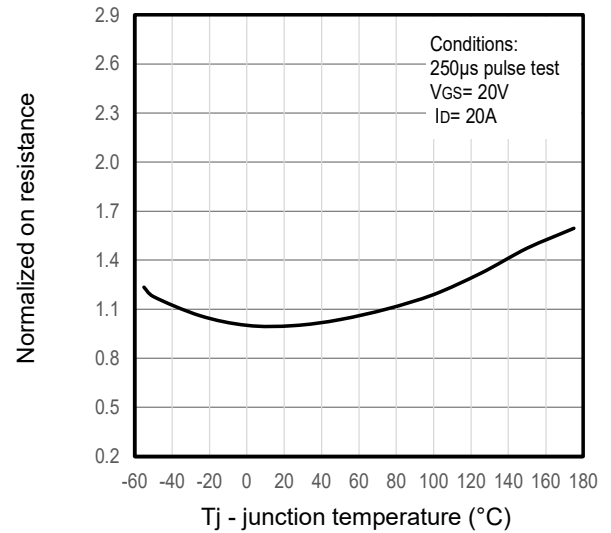
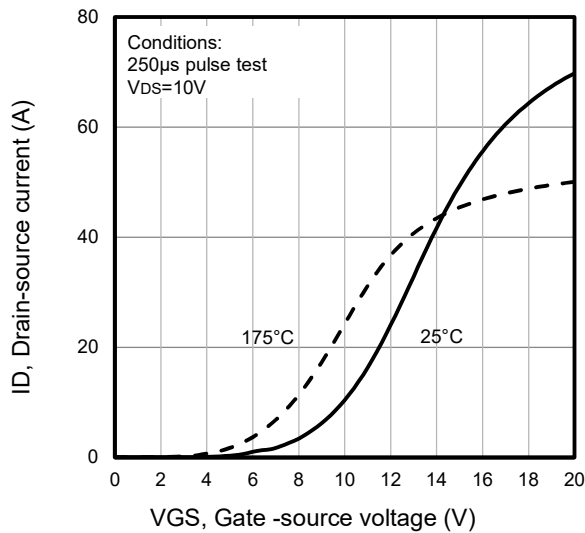
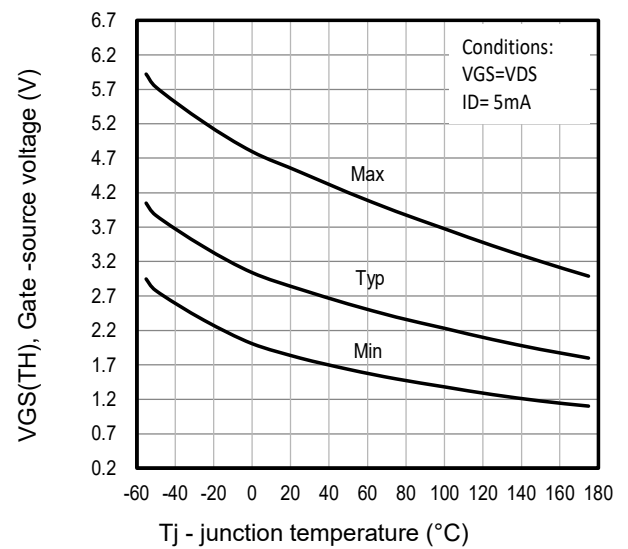
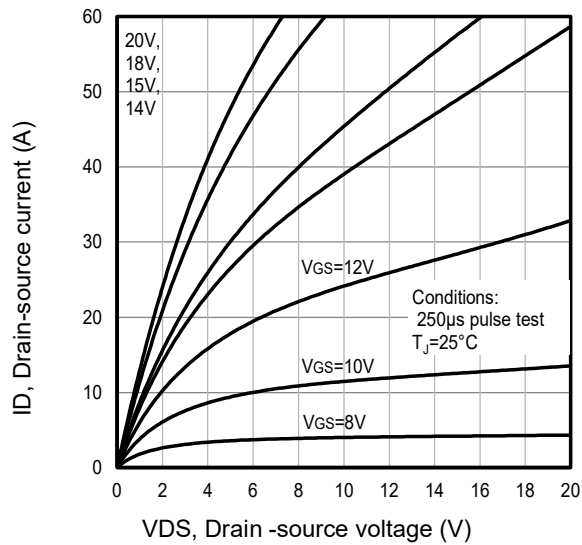
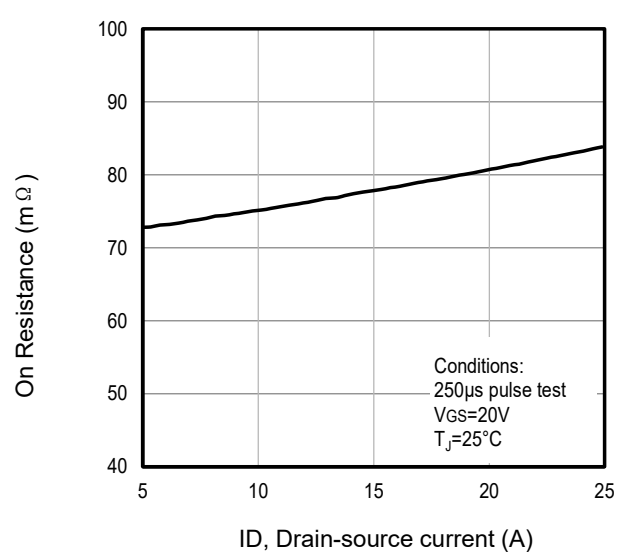
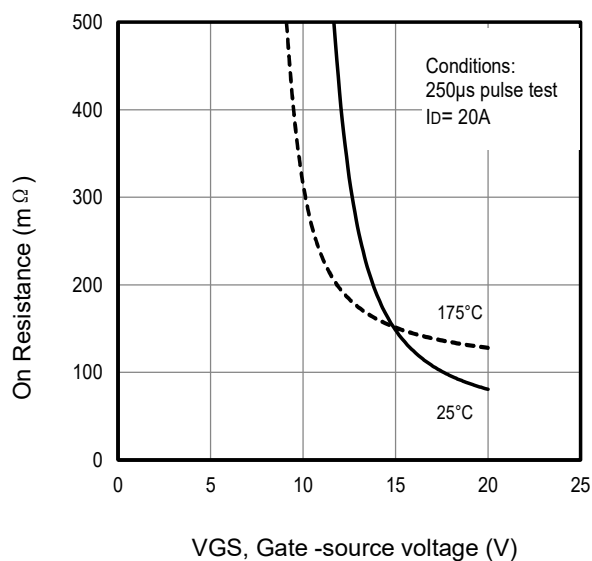


Fig3. Typical transfer characteristics

Fig4. Typical normalized on-resistance Vs. T_j



Typical Characteristics

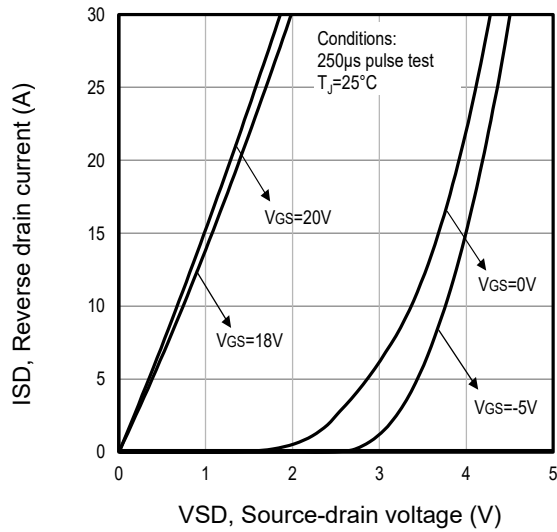


Fig7. Typical source-drain diode forward voltage

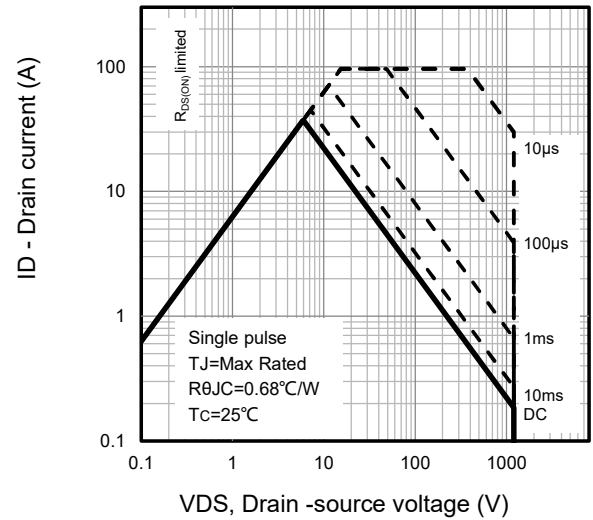


Fig8. Maximum safe operating area

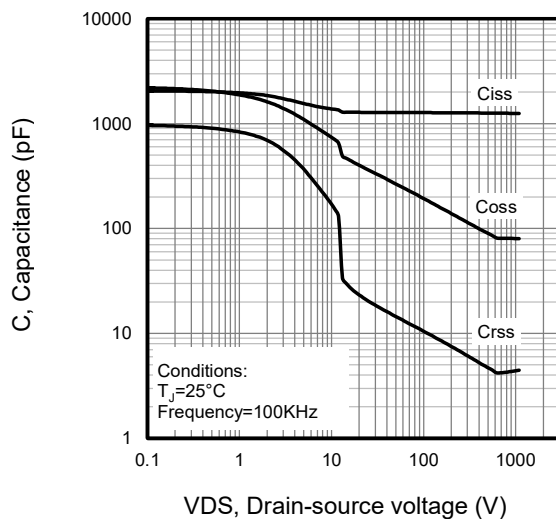


Fig9. Typical capacitance Vs. drain-source voltage

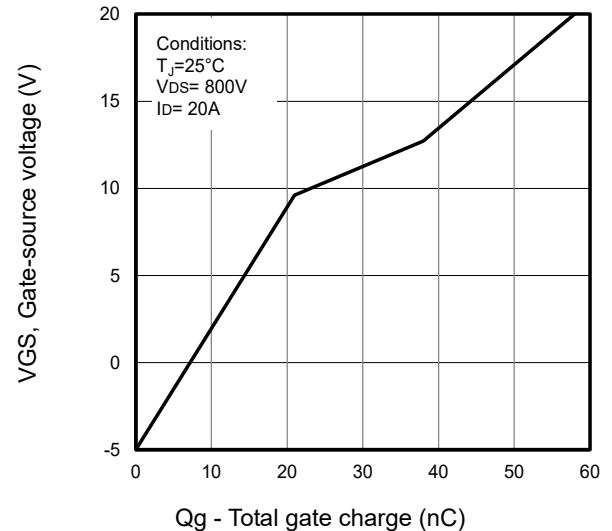


Fig10. Typical gate charge Vs. gate-source voltage

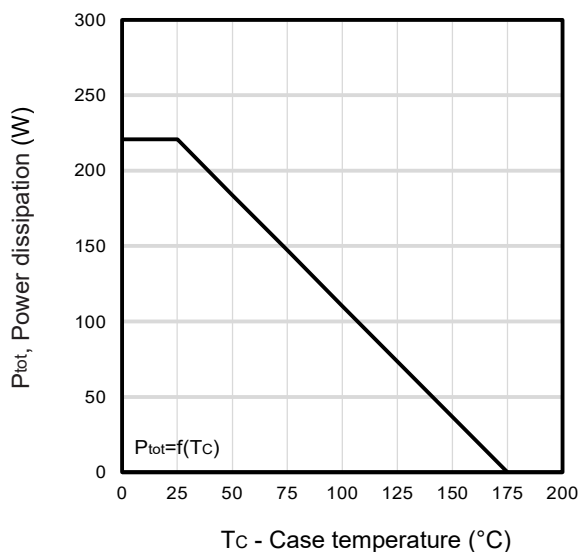


Fig11. Power dissipation Vs. case temperature

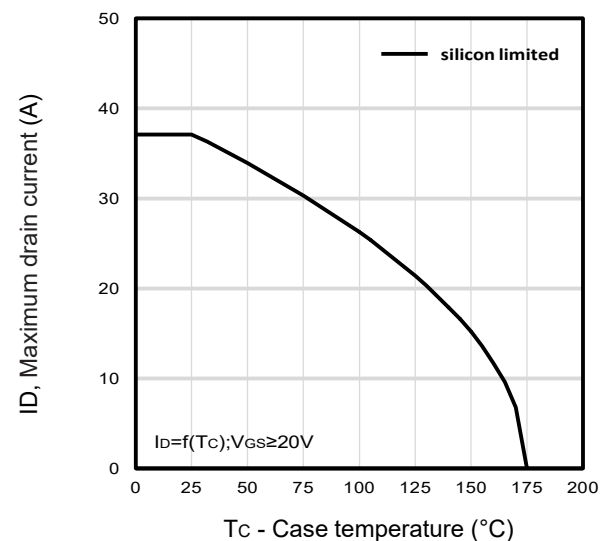
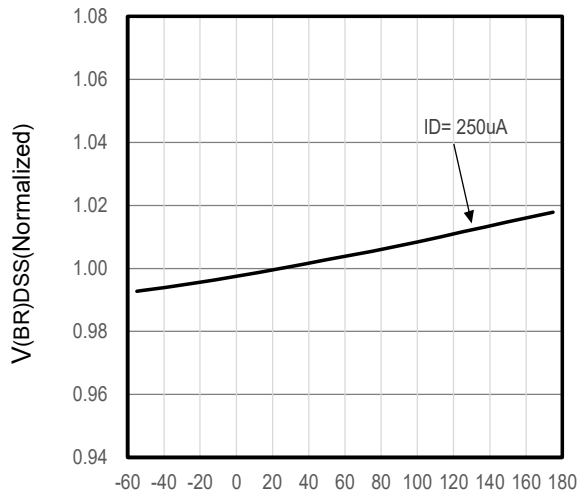


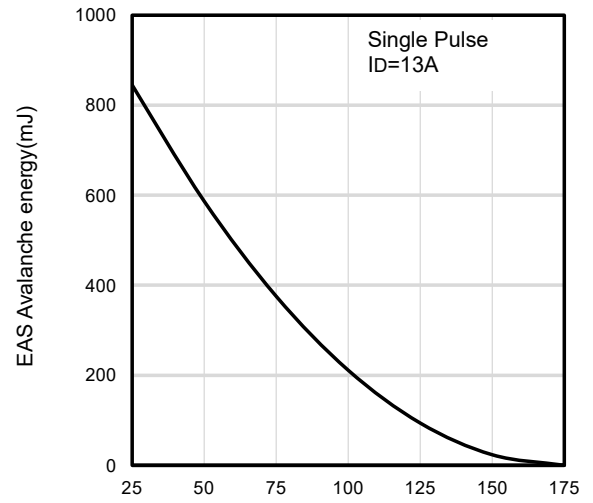
Fig12. Maximum drain current Vs. case temperature

Typical Characteristics



T_j - Junction temperature ($^{\circ}\text{C}$)

Fig13. Typical $V(\text{BR})\text{DSS}$ Vs T_j



Starting T_j junction temperature ($^{\circ}\text{C}$)

Fig14. Maximum avalanche energy vs temperature ($^{\circ}\text{C}$)

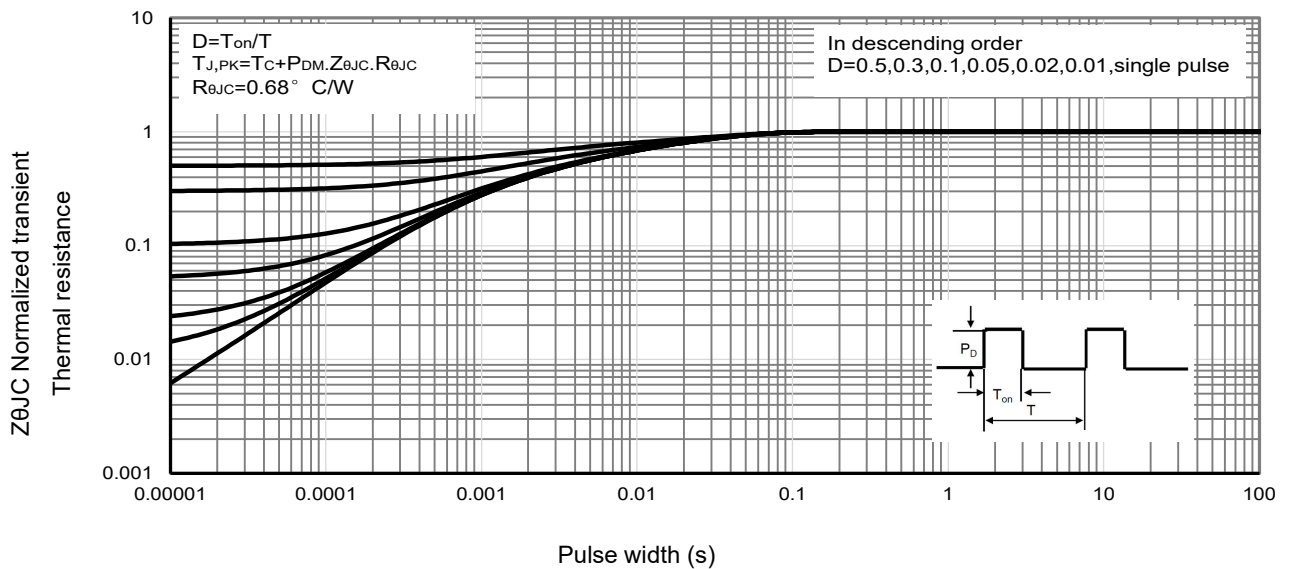


Fig15 . Normalized maximum transient thermal impedance

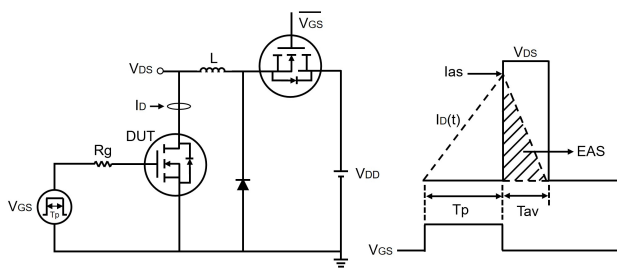


Fig16. Unclamped inductive test circuit and waveforms

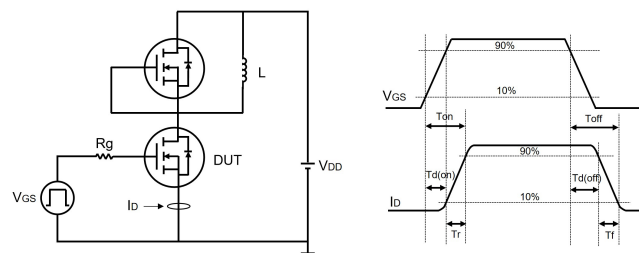
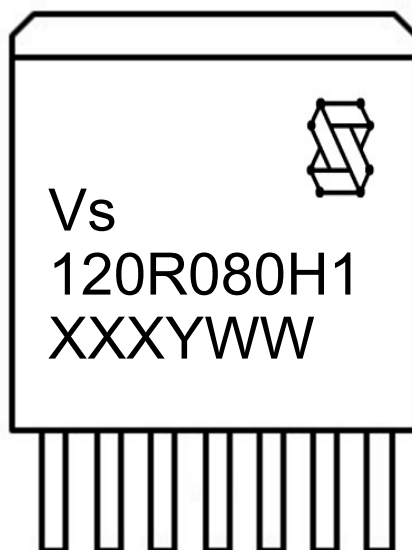


Fig17. Switching Energy Measurement Circuit

Marking Information



1st line: Vergiga Code (Vs) , Vergiga Logo

2nd line: Part Number (120R080H1)

3rd line: Date code (XXXYWW)

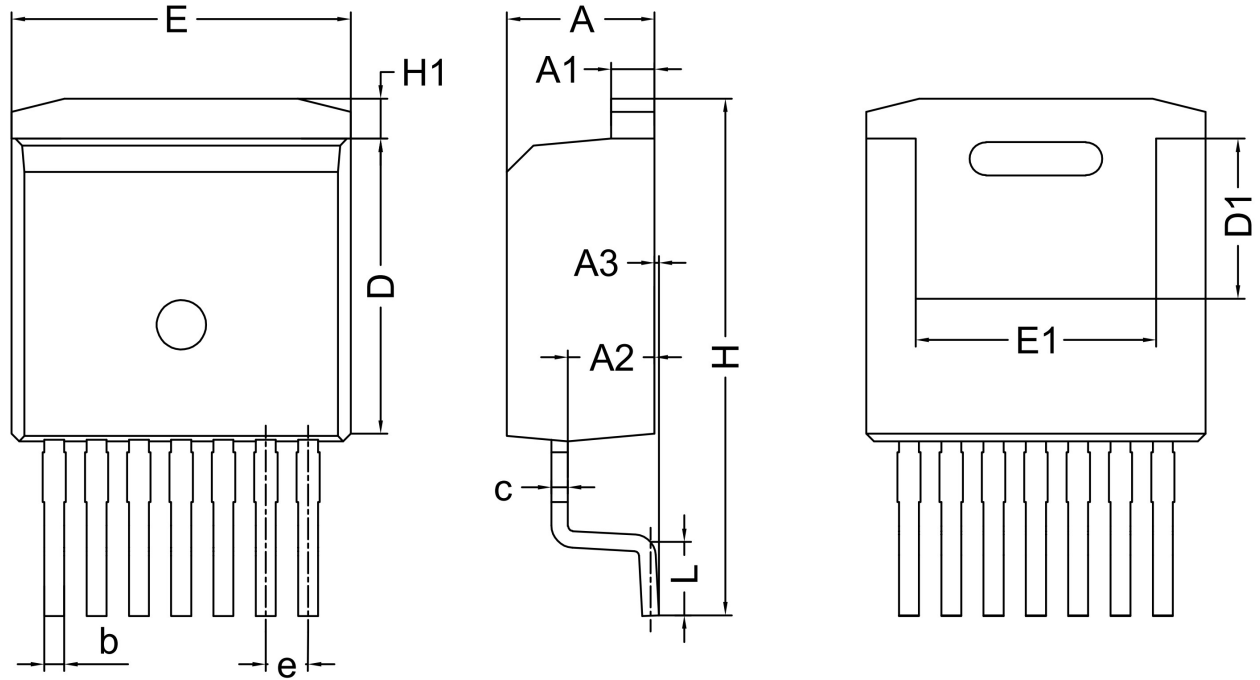
XXX: Wafer Lot Number Code , code changed with Lot Number

Y: Year Code , refer to table below

WW: Week Code (01 to 53)

Code	C	D	E	F	G	H	J	K	L	M	N	P	Q	R	S	T
Year	2015	2016	2017	2018	2019	2020	2021	2022	2023	2024	2025	2026	2027	2028	2029	2030

TO-263-7L Package Outline Data



Symbol	Dimensions (unit: mm)		
	Min	Typ	Max
A	4.30	4.43	4.56
A1	1.20	1.30	1.40
A2	2.45	2.60	2.75
A3	0.00	0.13	0.25
b	0.50	0.60	0.70
c	0.45	0.50	0.60
D	8.93	9.08	9.23
D1	4.65	4.80	4.95
e	1.27 BSC		
E	10.08	10.18	10.28
E1	6.82	7.22	7.62
H	15.00	15.50	16.00
H1	0.98	1.20	1.42
L	1.90	2.20	2.50

Notes:

1. Dimension "D" & "E" do NOT include mold flash, mold flash shall not exceed 0.127mm per side.